

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250874US2X DIV		SERIAL NO. <u>10/810,834</u> <u>New Application</u>	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Akiko MIYAHARA, et al.			
				FILING DATE <u>Herewith 3-29-2004</u>		GROUP <u>unassigned 3742</u>	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<u>re</u>	AA	5,523,550	06/04/96	Kimura			
<u>re</u>	AB	3,958,328	05/25/76	Lee			
<u>re</u>	AC	2,583,854	01/29/52	Kehbel			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<u>re</u>	AO	10-10901	01/16/98	Japan (with English Abstract)			X
<u>re</u>	AP	10-20704	01/23/98	Japan (with English Abstract)			X
<u>re</u>	AQ	10-153918	06/09/98	Japan (with English Abstract)			X
<u>re</u>	AR	10-282826	10/23/98	Japan (with English Abstract)			X
<u>re</u>	AS	11-316509	11/16/99	Japan (with English Abstract)			X
<u>re</u>	AT	2000-56598	02/25/00	Japan (with English Abstract)			X
<u>re</u>	AU	2000-105518	04/11/00	Japan (with English Abstract)			X
<u>re</u>	AV	2000-66543	03/03/2000	Japan (with English Abstract)			x
<u>re</u>	AW	8-179647	07/12/96	Japan (with English Abstract)			x
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AX						
	AY						
	AZ						
						<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <u>PHILIP H. LEUNG</u>					Date Considered <u>1-6-2005</u>		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.